VDIC
NAND Flash Memory

VDNF2T16XP193XX4V25
USER MANUAL

Version : A2

Document NO.： ORBITA/SIP-VDNF2T16XP193XX4V25-USM-01
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VDIC-NAND Flash Memory

HIGH-SPEED Asynchronous/Synchronous FALSH

128G×16bit

1. DESCRIPTION

Offered in 128Gx16bit, the VDNF2T16XP193XX4V25 is a2T-bit NAND Flash Memory with spare of 256Gb. The device operates at 3.3V. The I/O pins serve as the ports for address and data input/output as well as command input.

The VDNF2T16XP193XX4V25 device is stacked with eight packages. The operation of each package operates independently. The I/O ports and the control pins (ALE,CLE) of all banks in each package are connected.

Each package devices include an asynchronous data interface for high-performance I/O operations. These devices use a highly multiplexed 8-bit bus (DQx) to transfer commands, address, and data. There are five control signals used to implement the asynchronous data interface: CE#, CLE, ALE, WE#, and RE#. Additional signals control hardware write protection (WP#) and monitor device status (R/B#).

Each package devices additionally includes a synchronous data interface for high-performance I/O operations. When the synchronous interface is active, WE# becomes CLK and RE# becomes W/R#. Data transfers include a bidirectional data strobe (DQS).

A target is the unit of memory accessed by a chip enable signal. A target contains eight NAND Flash dies. A NAND Flash die is the minimum unit that can independently execute commands and report status. A NAND Flash die, in the ONFI specification, is referred to as a logical unit (LUN). For further details, see Device and Array Organization.

2. FEATURES

• Voltage Supply

-V_{CC} : 2.7 ~ 3.6 V

-V_{CCQ} :1.7~1.95V

• Organization

- Memory Cell Array : 8Packages x 16G x 16bit

– Page size x8: 8640 bytes (8192 + 448 bytes)

– Block size: 128 pages (1024K + 56K bytes)

– Plane size: 2 planes x 2048 blocks per plane

– Package size: 256Gb: 32,786 blocks

• Synchronous I/O performance

– Up to synchronous timing mode 5

– Clock rate: 10ns (DDR)

– Read/write throughput per pin: 200 MT/s

• Asynchronous I/O performance

– Up to asynchronous timing mode 5

–t RC/ t WC: 20ns (MIN)

– Read/write throughput per pin: 50 MT/s

• Array performance

– Read page: 35μs (MAX)

– Program page: 350μs (TYP)

– Erase block: 1.5ms (TYP)

• RESET (FFh) required as first command after power-on

• Reliability

– Endurance: 60,000 PROGRAM/ERASE cycles

• Data strobe (DQS) signals provide a hardware method for synchronizing data DQ in the synchronous Interface

• Package PGA193

3. BLOCK DIAGRAM

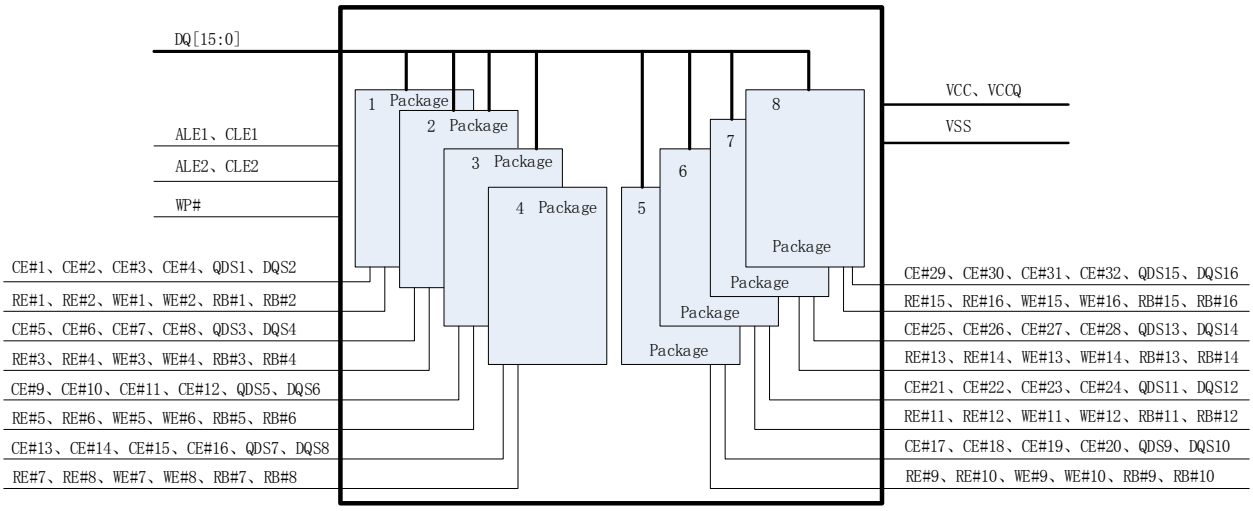


Figure 1:Block Diagram

4. DEVICE ORGANIZATION

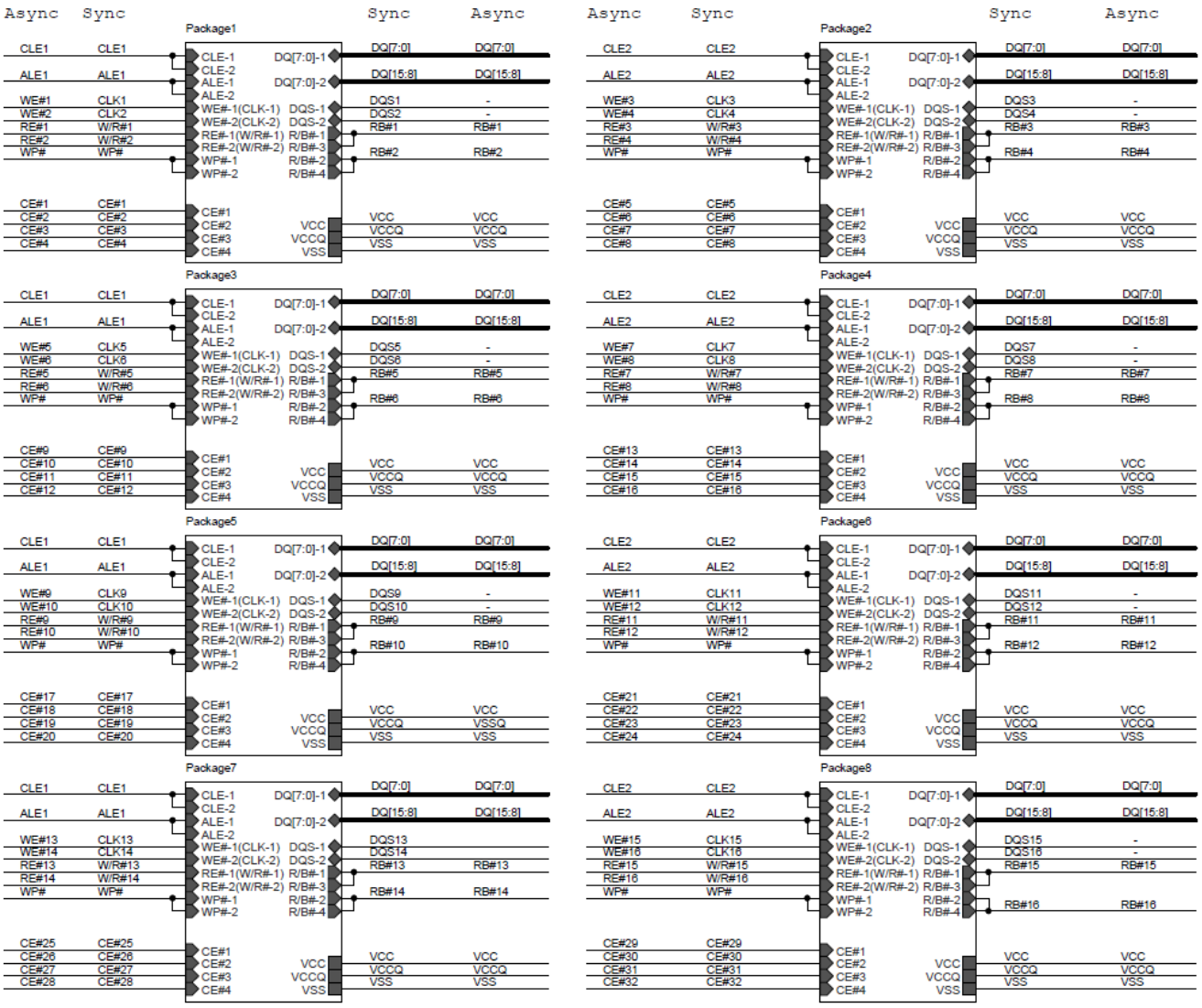


Figure 2:Device Organization

5. PIN DESCRIPTIONS– PGA-193

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
A	WP#	CE#3	DQ8	VSS	NC	DQ10	NC	CE#18	CE#9	RB#2	RB#14	RB#9	NC	DQ7	NC	CE#7
B	CE#11	CE#19	CE#27	VSS	DQ0	NC	CE#2	CE#26	CE#17	RB#6	RB#1	RB#13	DQ13	NC	ALE2	CE#15
C	CE#4	CE#12	CE#20	VSS	NC	DQ2	CE#10	CE#1	CE#25	RB#10	RB#5	DQ5	NC	DQ15	CLE2	CE#23
D	CE#28	ALE1	CLE1	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	CE#31
E	VCC	VCC	VCC	VCC	VSS								VSS	VSS	CE#16	CE#8
F	VCC	VCC	VCC	VCC									VSS	CE#6	CE#32	CE#24
G	VCCQ	VCCQ	VCCQ	VCCQ									VSS	CE#30	CE#22	CE#14
H	NC	DQ9	NC	VSS									VSS	CE#21	CE#13	CE#5
J	DQ11	NC	DQ1	VSS									VSS	RB#8	RB#4	CE#29
K	NC	DQ3	DQS14	VSS									VSS	RB#3	RB#16	RB#12
L	DQS10	DQS6	DQS2	VSS									VSS	RB#15	RB#11	RB#7
M	DQS13	DQS9	DQS5	VSS									VSS	VSS	VSS	VSS
N	DQS1	RE#13	RE#9	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS	VSS
P	RE#5	RE#6	WE#2	WE#14	WE#9	NC	DQ14	NC	DQS12	DQS7	WE#4	WE#16	WE#11	RE#16	VSS	VSS
R	RE#1	RE#10	WE#6	WE#1	WE#13	DQ4	NC	DQS4	DQS16	DQS11	WE#8	WE#3	WE#15	RE#4	RE#8	RE#12
T	RE#2	RE#14	WE#10	WE#5	DQ12	NC	DQ6	DQS8	DQS3	DQS15	WE#12	WE#7	RE#3	RE#7	RE#11	RE#15

TOP VIEW

Figure 3:Signal Assignments

Table 1:Signal Descriptions

Asynchronous signal[1]	Synchronous signal[1]	Type	Function
DQ0~DQ15	DQ0~DQ15	I/O	**Data inputs/outputs:** The bidirectional I/Os transfer address, data, and command information.
CLE1、CLE2	CLE1、CLE2	Input	**Command latch enable:** Loads a command from DQx into the command register.
CE#1 ~CE#32	CE#1 ~CE#32	Input	**Chip enable:** Enables or disables one or more die (LUNs) in a package's target.
ALE1、ALE2	ALE1、ALE2	Input	**Address latch enable:** Loads an address from DQx into the address register.
RE#1~RE#16	W/R#1~W/R#16	Input	**Read enable and write/read:** RE# transfers serial data from the NAND Flash to the host system when the asynchronous interface is active. When the synchronous interface is active, W/R# controls the direction of DQx and DQS.
-	DQS1~DQS16	I/O	**Data strobe:** Provides a synchronous reference for data input and out-put.
WE#1~WE#16	CLK1~CLK16	Input	**Write enable and clock:** WE# transfers commands, addresses, and seri-al data from the host system to the NAND Flash when the

Asynchronous signal[1]	Synchronous signal[1]	Type	Function
			asynchronous interface is active. When the synchronous interface is active, CLK latches command and address cycles.
WP#	WP#	Input	**Write protect:** Enables or disables array PROGRAM and ERASE operations.
RB#1~RB#16	RB#1~RB#16	Output	**Ready/busy:** An open-drain, active-low output that requires an external pull-up resistor. This signal indicates target array activity.
VCC	VCC	Supply	**VCC:** Core power supply
VCCQ	VCCQ	Supply	**VCCQ:** I/O power supply
VSS	VSS	Supply	**VSS:** Core ground connection
NC	NC	-	**NO connect:** NCs are not internally connected. They can be driven or left unconnected.

Notes:

1. See Device Organization for detailed signal connections.

6. ELECTRICAL SPECIFICATIONS

6.1. Absolute Maximum Ratings

Table 2:Absolute Maximum Ratings

Characteristics	Symbol	Maximum ratings	Unit
Voltage on VCC supply relative to Vss	V_{CC}	-0.6 to +4.6	V
Voltage on VCCQ supply relative to VssQ	V_{CCQ}	-0.6 to +4.6	
Voltage on any pin relative to Vss	V_{IN}	-0.6 to +4.6	V
Power Dissipation	P_D	2.0	W
Operating Temperature Range	T_{OPR}	-55~ +125	℃
Storage Temperature Range	T_{STG}	-65 to +150	℃

Notes:1. Voltage on any pin relative to V SS

6.2. Recommended DC Operating Conditions

Table 3:Recommended DC Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit

Parameter	Symbol	Min	Typ	Max	Unit
VCC Supply voltage	V_{CC}	2.7	3.3	3.6	V
VCCQ supply voltage	V_{CCQ}	1.7	1.8	1.95	V
Input high voltage	V_{IH}	$0.8\times V_{CCQ}$	——	$V_{CCQ}+0.3$	V
Input low voltage	V_{IL}	-0.3	——	$0.2\times V_{CCQ}$	V

6.3. DC And Operating Characteristics

Asynchronous Mode

Table 4:DC And Operating Characteristics(Asynchronous Mode)

Parameter	Symbol	Test Conditions	Min	Max	Unit
Output voltage low level	V_{OL}	V_{CC}=3.6V, V_{CCQ}=1.95V, I_{OL} =2.1mA	—	0.39	V
Output voltage high level	V_{OH}	V_{CC}=2.7V,V_{CCQ}=1.7V,I_{OH}= -0.4mA	1.36	—	V

Synchronous Mode

Table 5:DC And Operating Characteristics(Synchronous Mode)

Parameter	Symbol	Test Conditions	Min	Max	Unit
Output voltage low level	V_{OL}	V_{CC}=3.6V, V_{CCQ}=1.95V, I_{OL} =2.1mA	—	0.39	V
Output voltage high level	V_{OH}	V_{CC}=2.7V,V_{CCQ}=1.7V,I_{OH}= -0.4mA	1.36	—	V

7. TYPICAL APPLICATION

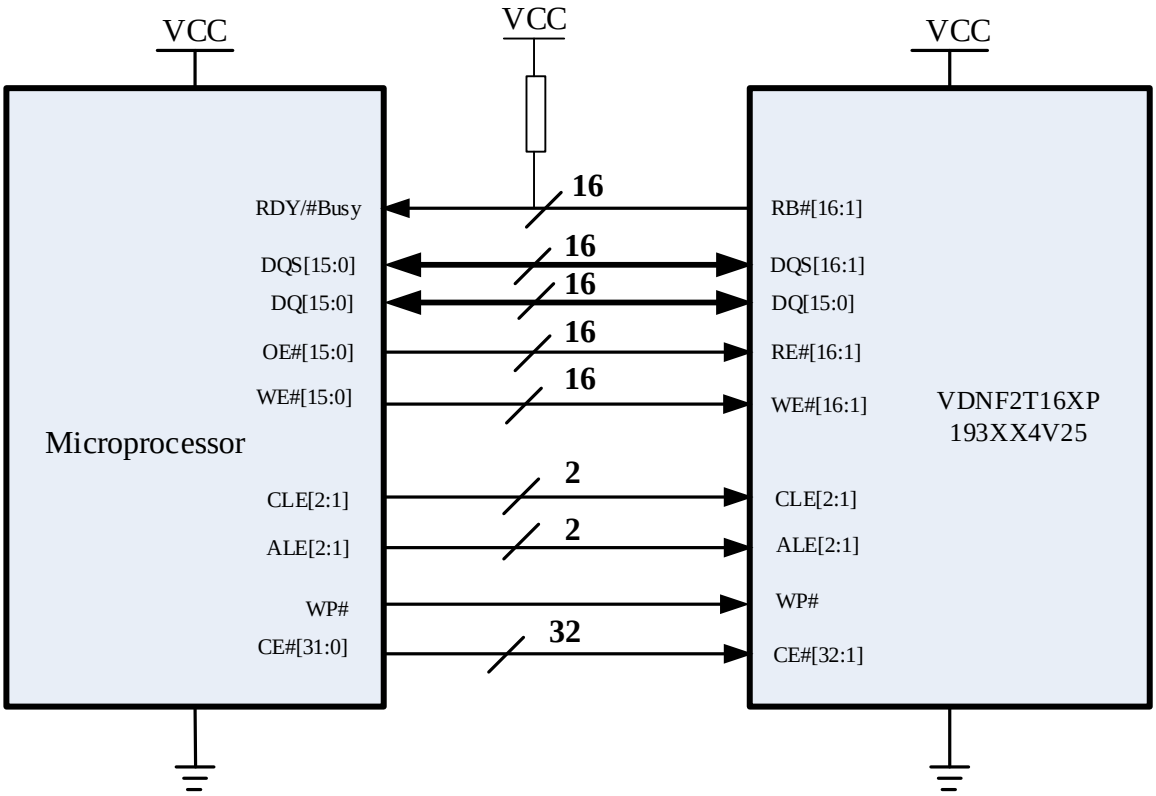


Figure 4:Typical Application

Table 6: Recommended Signal Combination

Group	Signal Combination								
1	CE#1	DQ[7:0]	CLE1	ALE1	DQS1	WE#1	RE#1	RB#1	WP#
	CE#2	DQ[15:8]			DQS2	WE#2	RE#2	RB#2	
2	CE#3	DQ[7:0]	CLE1	ALE1	DQS1	WE#1	RE#1	RB#1	
	CE#4	DQ[15:8]			DQS2	WE#2	RE#2	RB#2	
3	CE#5	DQ[7:0]	CLE2	ALE2	DQS3	WE#3	RE#3	RB#3	
	CE#6	DQ[15:8]			DQS4	WE#4	RE#4	RB#4	
4	CE#7	DQ[7:0]	CLE2	ALE2	DQS3	WE#3	RE#3	RB#3	
	CE#8	DQ[15:8]			DQS4	WE#4	RE#4	RB#4	
5	CE#9	DQ[7:0]	CLE1	ALE1	DQS5	WE#5	RE#5	RB#5	
	CE#10	DQ[15:8]			DQS6	WE#6	RE#6	RB#6	
6	CE#11	DQ[7:0]	CLE1	ALE1	DQS5	WE#5	RE#5	RB#5	
	CE#12	DQ[15:8]			DQS6	WE#6	RE#6	RB#6	

Group	Signal Combination								
7	CE#13	DQ[7:0]	CLE2	ALE2	DQS7	WE#7	RE#7	RB#7	
	CE#14	DQ[15:8]			DQS8	WE#8	RE#8	RB#8	
8	CE#15	DQ[7:0]	CLE2	ALE2	DQS7	WE#7	RE#7	RB#7	
	CE#16	DQ[15:8]			DQS8	WE#8	RE#8	RB#8	
9	CE#17	DQ[7:0]	CLE1	ALE1	DQS9	WE#9	RE#9	RB#9	
	CE#18	DQ[15:8]			DQS10	WE#10	RE#10	RB#10	
10	CE#19	DQ[7:0]	CLE1	ALE1	DQS9	WE#9	RE#9	RB#9	
	CE#20	DQ[15:8]			DQS10	WE#10	RE#10	RB#10	
11	CE#21	DQ[7:0]	CLE2	ALE2	DQS11	WE#11	RE#11	RB#11	
	CE#22	DQ[15:8]			DQS12	WE#12	RE#12	RB#12	
12	CE#23	DQ[7:0]	CLE2	ALE2	DQS11	WE#11	RE#11	RB#11	
	CE#24	DQ[15:8]			DQS12	WE#12	RE#12	RB#12	
13	CE#25	DQ[7:0]	CLE1	ALE1	DQS13	WE#13	RE#13	RB#13	
	CE#26	DQ[15:8]			DQS14	WE#14	RE#14	RB#14	
14	CE#27	DQ[7:0]	CLE1	ALE1	DQS13	WE#13	RE#13	RB#13	
	CE#28	DQ[15:8]			DQS14	WE#14	RE#14	RB#14	
15	CE#29	DQ[7:0]	CLE2	ALE2	DQS15	WE#15	RE#15	RB#15	
	CE#30	DQ[15:8]			DQS16	WE#16	RE#16	RB#16	
16	CE#31	DQ[7:0]	CLE2	ALE2	DQS15	WE#15	RE#15	RB#15	
	CE#32	DQ[15:8]			DQS16	WE#16	RE#16	RB#16	

8. ORDERING INFORMATION

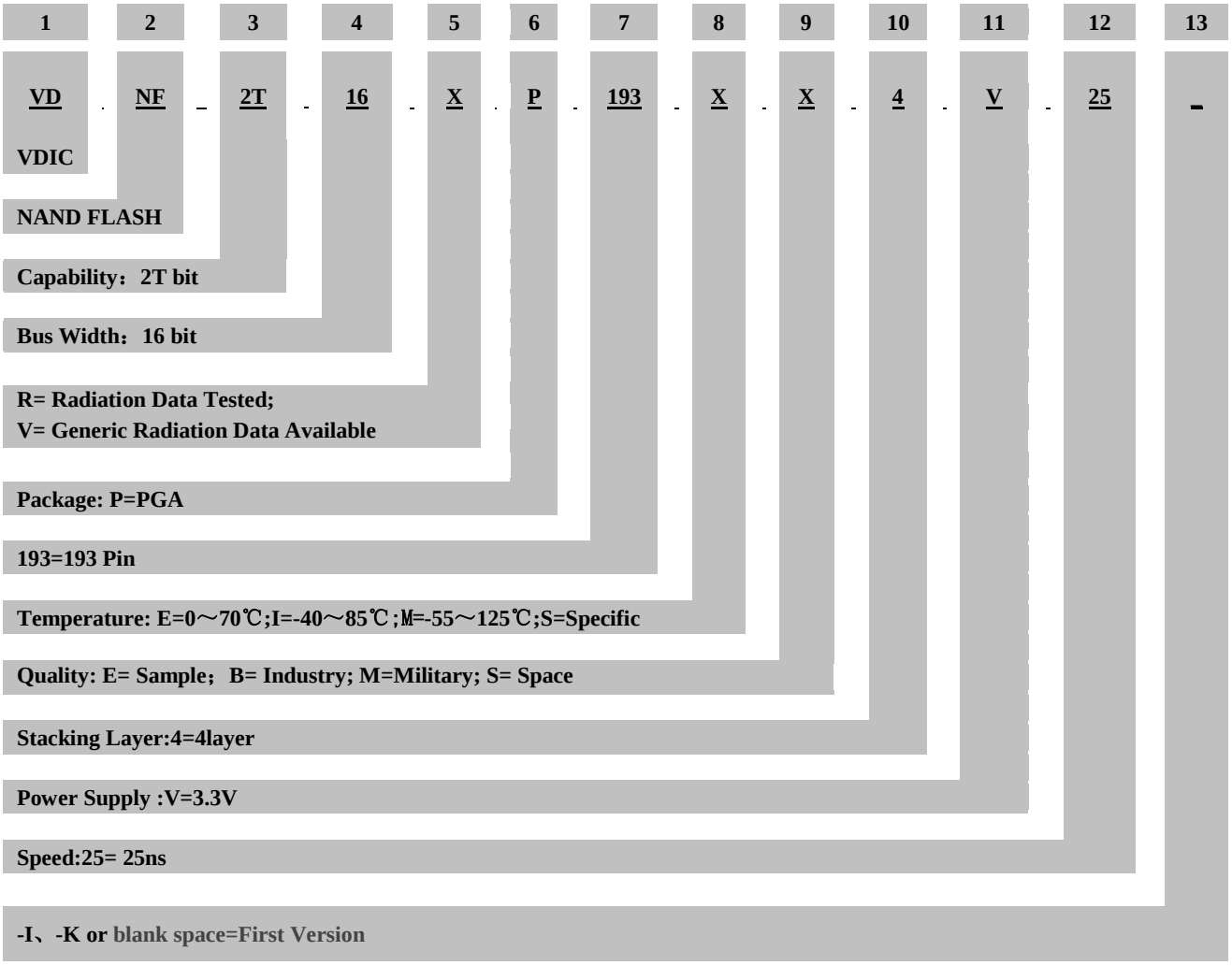


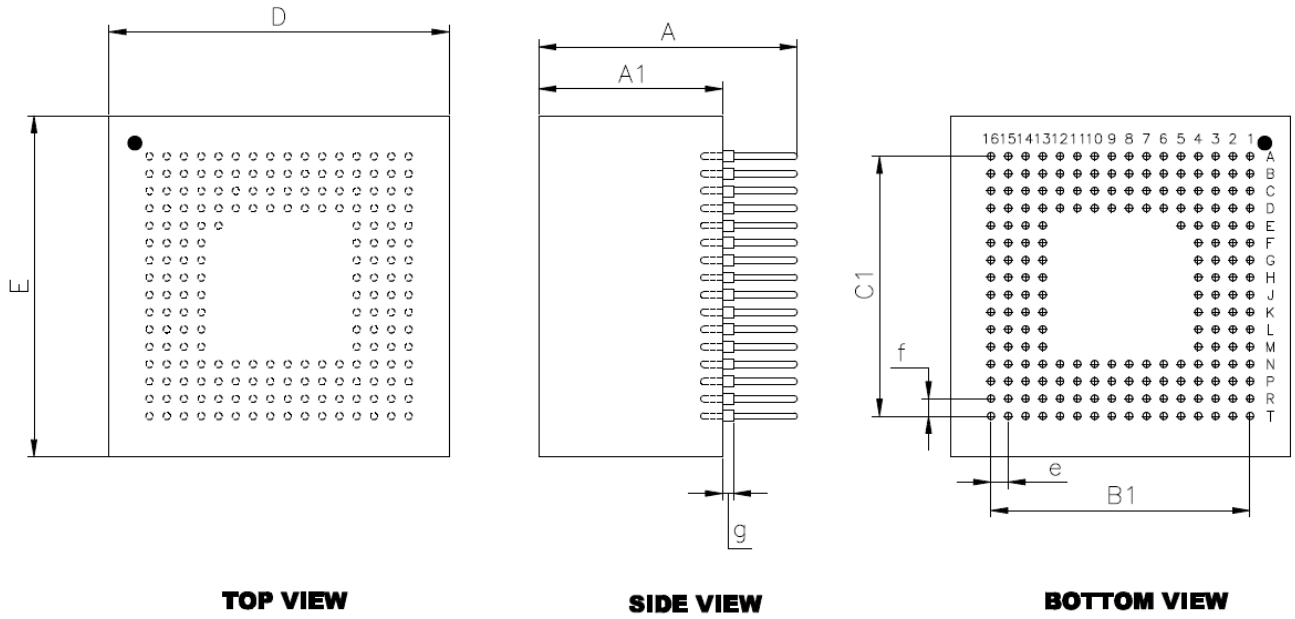
Table 6:Part Information

Part Number	Capacity (bit)	Bus Width (bit)	Radiation			Packaging	Temperature (℃)
			TID[1]	SEL[2]	SEU[3]		
VDNF2T16VP193EE4V25	2T	16	-	-	-	PGA193	0 ~ + 70
VDNF2T16VP193IB4V25	2T	16	-	-	-	PGA193	-40 ~ + 85
VDNF2T16VP193MM4V25	2T	16	-	-	-	PGA193	-55 ~ + 125
VDNF2T16VP193MB4V25	2T	16	-	-	-	PGA193	-55 ~ + 125

[1] TID: Total Dose（Krads(Si)）
[2] SEL: LET Threshold（Mev.cm2/mg）
[3] SEU:SEU Threshold （Mev.cm2/mg）

VDNF2T16RP193MS4V25	2T	16	>60	>62.5	1.3	PGA193	-55 ~ + 125

9. DEVICE DIMENSIONS



TOP VIEW **SIDE VIEW** **BOTTOM VIEW**

	Min	Max
A	18.7	19.3
A1	13.2	13.8
D	25.8	26.2
E	25.8	26.2
B1	e*15	
C1	f*15	
b	0.46±0.05	
e	1.27	
f	1.27	
g	0.8	
NOTE：1. Unit：mm		

Figure 5:Device Dimensions

10. REVISION HISTORY

Revision	Date	Description of Change
A0	Jun 3,2017	First Created
A1	Mar 27,2018	Add or reduce chapters
A2	May 22,2018	Modified FEATURES